

SANYO Semiconductors DATA SHEET

FSS162—General-Purpose Switching Device Applications

Features

- · Low ON-resistance.
- · 4V drive.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		-30	V
Gate-to-Source Voltage	VGSS		±20	V
Drain Current (DC)	ID		-8	Α
Drain Current (PW≤10s)	ID	Duty cycle≤1%	-10	Α
Drain Current (PW≤10μs)	IDP	Duty cycle≤1%	-52	Α
Allowable Power Dissipation	PD	Mounted on a ceramic board (1200mm²X0.8mm), PW≤10s	2.4	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Unit
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=-1mA, VGS=0V	-30			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =-30V, V _{GS} =0V			-1	μΑ
Gate-to-Source Leakage Current	IGSS	V _{GS} = ±16V, V _{DS} =0V			±10	μΑ
Cutoff Voltage	VGS(off)	VDS=-10V, ID=-1mA	-1.0		-2.4	V
Forward Transfer Admittance	yfs	V _{DS} =-10V, I _D =-8A	9	15		S
Static Drain-to-Source On-State Resistance	R _{DS} (on)1	I _D =-8A, V _G S=-10V		18	24	mΩ
	RDS(on)2	ID=-4A, VGS=-4.5V		26	37	mΩ
	R _{DS} (on)3	I _D =-4A, V _G S=-4V		30	43	mΩ
Input Capacitance	Ciss	V _{DS} =-10V, f=1MHz		2500		pF
Output Capacitance	Coss	V _{DS} =-10V, f=1MHz		460		pF
Reverse Transfer Capacitance	Crss	V _{DS} =-10V, f=1MHz		370		pF

Marking: S162 Continued on next page.

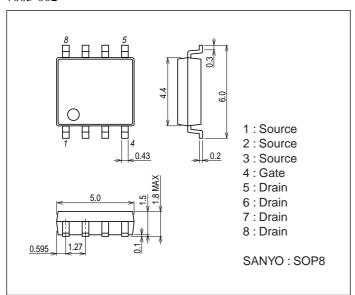
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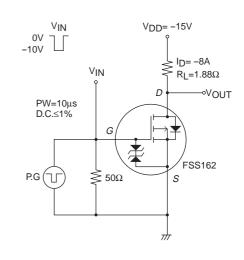
Parameter	Symbol	Conditions	Ratings			Unit
	Symbol		min	typ	max	Oill
Turn-ON Delay Time	td(on)	See specified Test Circuit.		28		ns
Rise Time	t _r	See specified Test Circuit.		180		ns
Turn-OFF Delay Time	t _d (off)	See specified Test Circuit.		140		ns
Fall Time	tf	See specified Test Circuit.		100		ns
Total Gate Charge	Qg	V _{DS} =-10V, V _{GS} =-10V, I _D =-8A		47		nC
Gate-to-Source Charge	Qgs	V _{DS} =-10V, V _{GS} =-10V, I _D =-8A		7		nC
Gate-to-Drain "Miller" Charge	Qgd	V _{DS} =-10V, V _{GS} =-10V, I _D =-8A		9		nC
Diode Forward Voltage	V _{SD}	I _S =-8A, V _{GS} =0V		-0.83	-1.5	V

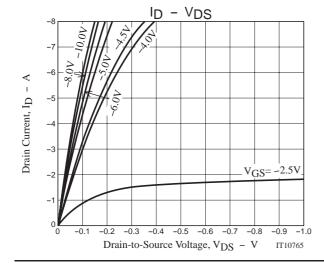
Package Dimensions

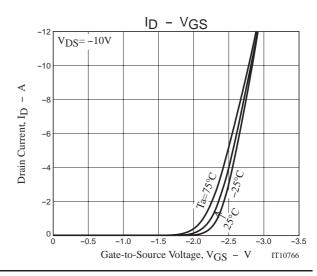
unit : mm 7005-002

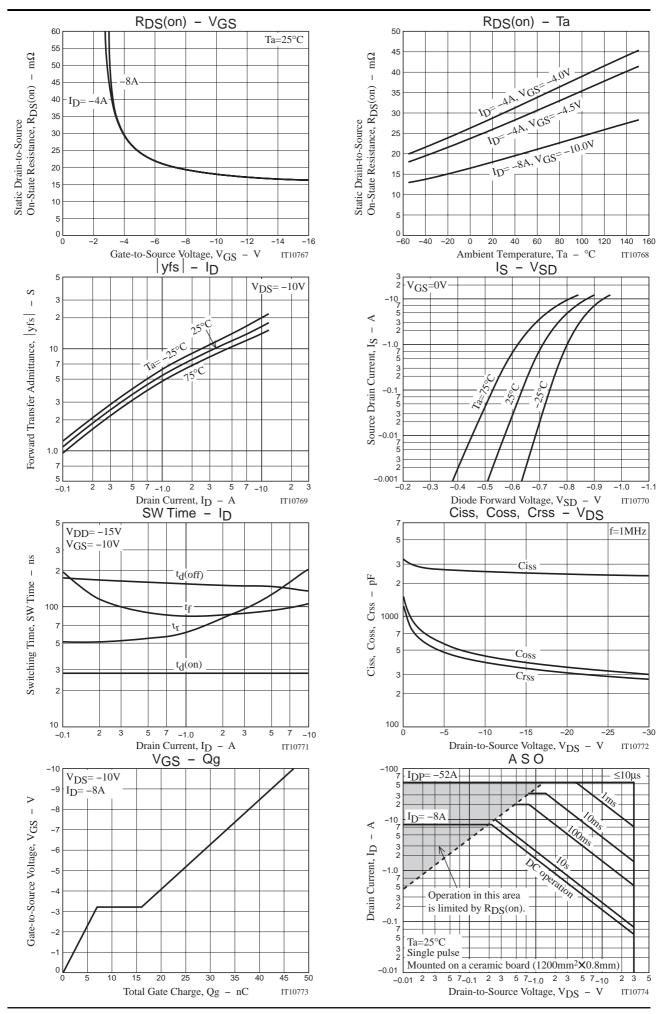


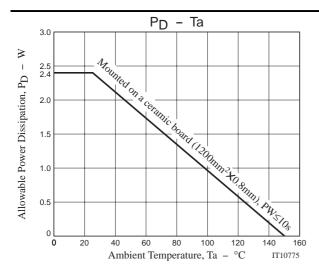
Switching Time Test Circuit











Note on usage: Since the FSS162 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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